



**AO4850**

**Dual N-Channel Enhancement Mode Field Effect Transistor**

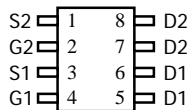


**General Description**

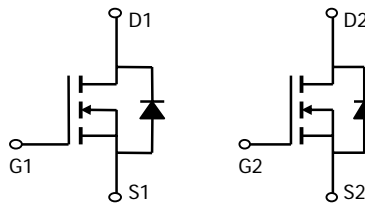
The AO4850 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. The two MOSFETs may be used in H-bridge, Inverters and other applications. AO4850 is Pb-free (meets ROHS & Sony 259 specifications).

**Features**

$V_{DS}$  (V) = 75V  
 $I_D$  = 3.1A ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 130m $\Omega$  ( $V_{GS}$  = 10V)  
 $R_{DS(ON)}$  < 165m $\Omega$  ( $V_{GS}$  = 4.5V)



**SOIC-8**



**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                                      | Symbol         | Maximum                |              | Units            |   |
|--|----------------|------------------------|--------------|------------------|---|
|  |                | 10 Sec                 | Steady State |                  |   |
| Drain-Source Voltage                           | $V_{DS}$       | 75                     |              | V                |   |
| Gate-Source Voltage                            | $V_{GS}$       | $\pm 25$               |              | V                |   |
| Continuous Drain Current <sup>A</sup>          | $I_D$          | $T_A=25^\circ\text{C}$ | 3.1          | 2.3              | A |
|  |                | $T_A=70^\circ\text{C}$ | 2.4          | 1.8              |   |
| Pulsed Drain Current <sup>B</sup>              | $I_{DM}$       | 15                     |              |                  |   |
| Power Dissipation                              | $P_D$          | $T_A=25^\circ\text{C}$ | 2            | 1.1              | W |
|  |                | $T_A=70^\circ\text{C}$ | 1.3          | 0.7              |   |
| Avalanche Current <sup>B</sup>                 | $I_{AR}$       | 10                     |              | A                |   |
| Repetitive avalanche energy 0.3mH <sup>B</sup> | $E_{AR}$       | 15                     |              | mJ               |   |
| Junction and Storage Temperature Range         | $T_J, T_{STG}$ | -55 to 150             |              | $^\circ\text{C}$ |   |

**Thermal Characteristics**

| Parameter  | Symbol          | Typ | Max  | Units              |
|--|-----------------|-----|------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> $t \leq 10\text{s}$ | $R_{\theta JA}$ | 50  | 62.5 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Ambient <sup>A</sup> Steady-State        |                 | 82  | 110  | $^\circ\text{C/W}$ |
| Maximum Junction-to-Lead <sup>C</sup> Steady-State           | $R_{\theta JL}$ | 41  | 50   | $^\circ\text{C/W}$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max    | Units         |
|-----------------------------|---------------------------------------|--|-----|------|--------|---------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |        |               |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=10\text{mA}$ , $V_{GS}=0\text{V}$   | 75  |      |        | V             |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=75\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                 |     |      | 1<br>5 | $\mu\text{A}$ |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 25\text{V}$                                       |     |      | 100    | nA            |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=250\mu\text{A}$   | 1   | 2.3  | 3      | V             |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=10\text{V}$ , $V_{DS}=5\text{V}$   | 15  |      |        | A             |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}$ , $I_D=3.1\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 105  | 130    | m $\Omega$    |
|                             |                                       | $V_{GS}=4.5\text{V}$ , $I_D=2\text{A}$   |     | 126  | 165    |               |
|                             |                                       | $V_{GS}=10\text{V}$ , $I_D=3.1\text{A}$  |     | 10   |        | S             |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}$ , $I_D=3.1\text{A}$   |     | 10   |        | S             |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}$ , $V_{GS}=0\text{V}$   |     | 0.77 | 1      | V             |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |      | 2.5    | A             |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |        |               |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}$ , $V_{DS}=30\text{V}$ , $f=1\text{MHz}$                         |     | 290  | 380    | pF            |
| $C_{oss}$                   | Output Capacitance                    |  |     | 54   |        | pF            |
| $C_{rss}$                   | Reverse Transfer Capacitance          |  |     | 24   |        | pF            |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$                          |     | 2.4  | 3.5    | $\Omega$      |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |        |               |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}$ , $V_{DS}=30\text{V}$ , $I_D=3.1\text{A}$                      |     | 5.14 | 7      | nC            |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 2.34 |        | nC            |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 0.97 |        | nC            |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 1.18 |        | nC            |
| $t_{D(on)}$                 | Turn-On Delay Time                    | $V_{GS}=10\text{V}$ , $V_{DS}=30\text{V}$ , $R_L=9.7\Omega$ ,<br>$R_{GEN}=3\Omega$ |     | 4    |        | ns            |
| $t_r$                       | Turn-On Rise Time                     |  |     | 3.4  |        | ns            |
| $t_{D(off)}$                | Turn-Off Delay Time                   |  |     | 14.4 |        | ns            |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 2.4  |        | ns            |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=3.1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                |     | 30.2 | 45     | ns            |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=3.1\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                                |     | 21.5 |        | nC            |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $t \leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using  $<300 \mu\text{s}$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

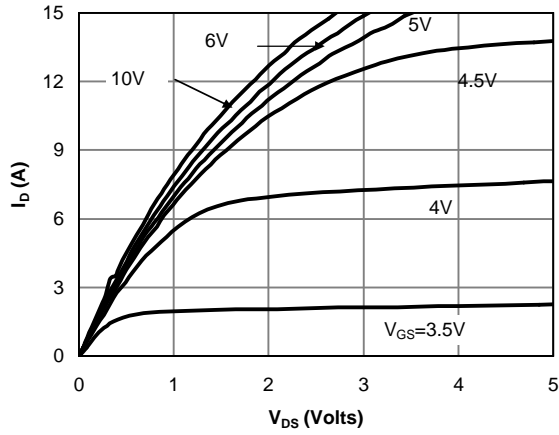


Fig 1: On-Region Characteristics

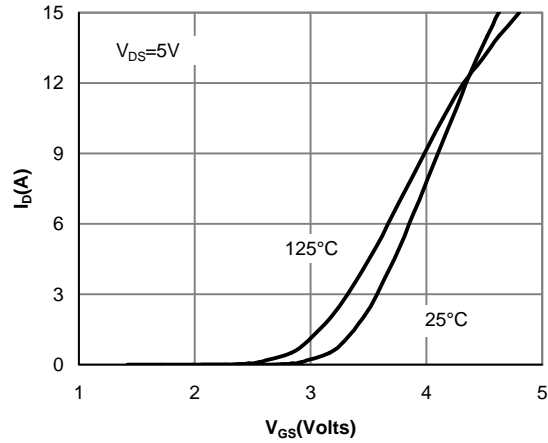


Figure 2: Transfer Characteristics

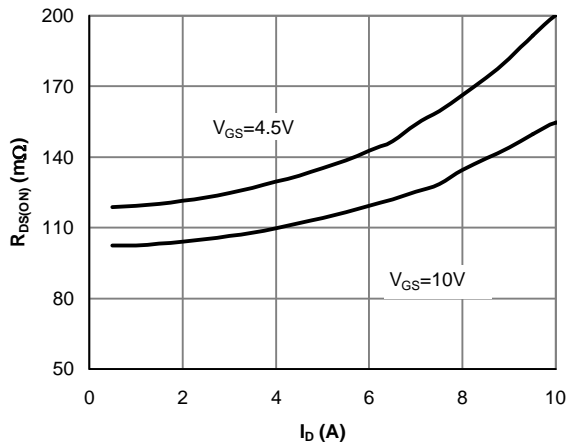


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

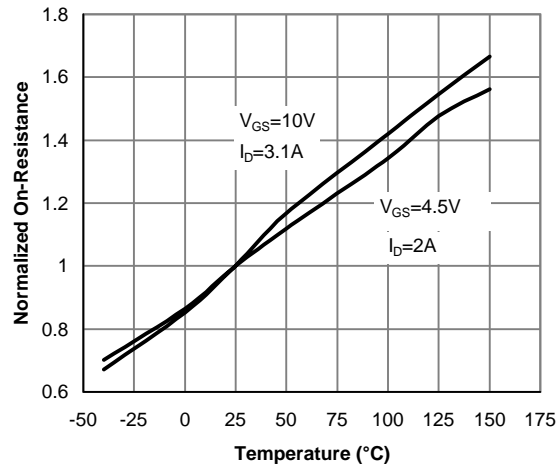


Figure 4: On-Resistance vs. Junction Temperature

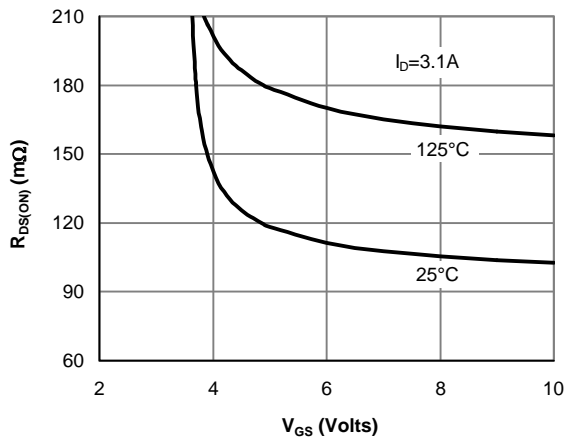


Figure 5: On-Resistance vs. Gate-Source Voltage

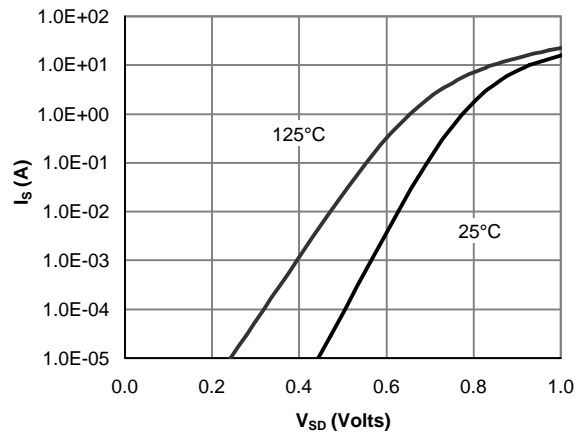


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

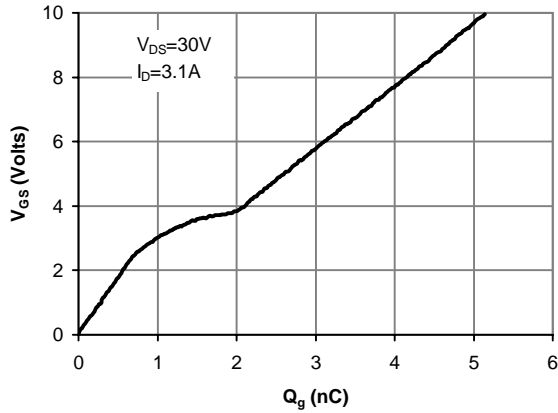


Figure 7: Gate-Charge Characteristics

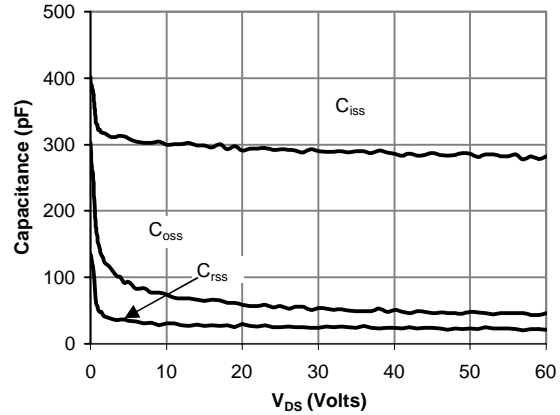


Figure 8: Capacitance Characteristics

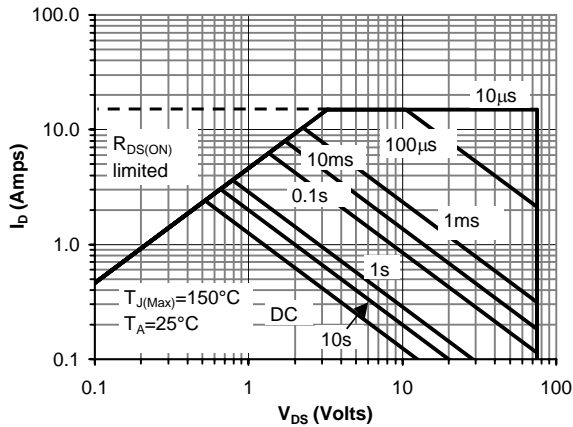


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

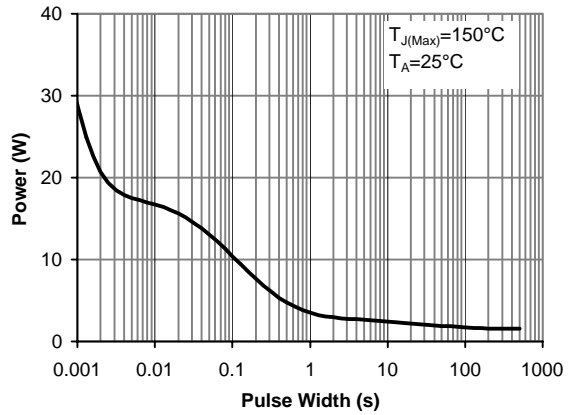


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

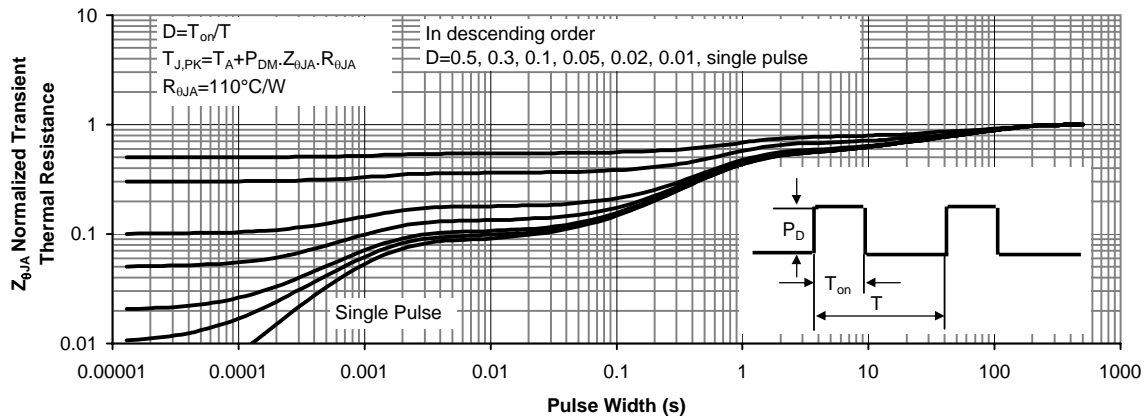


Figure 11: Normalized Maximum Transient Thermal Impedance